ALPEN-ADRIA UNIVERSITÄT KLAGENFURT

INVITATION TO THE PRESENTATION ABOUT THE WORK-PLACEMENT

Evaluation of X-ray micrographs of power semiconductors

Chiara Nadine Wang | Universität Klagenfurt

Chaired by Jürgen Pilz | Department of Statistics

Friday, 29 May 2020 | 14:00–14:45

https://classroom.aau.at/b/jpi-rjr-3wy

ABSTRACT

The internship semester took place in the department of failure analysis at Infineon Technologies Austria AG. In the laboratory analyses of failed semiconductor devices are performed. One of these analysis methods is the X-ray. The main topic of this internship semester was the evaluation of X-ray-micrographs with the aid of the image processing program “ImageJ”.

We hope to see you there!